

N-CHANNEL SILICON POWER MOSFET

FUJI POWER MOSFET
Super FAP-G Series
■ Features

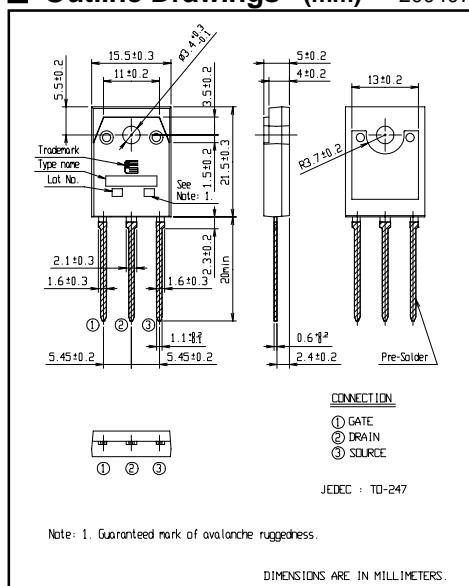
- High speed switching, Low on-resistance
- Low driving power, Avalanche-proof
- No secondary breakdown

■ Applications

- Switching regulators
- UPS (Uninterruptible Power Supply)
- DC-DC converters

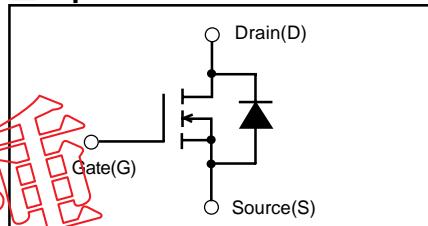
■ Maximum ratings and characteristic
● Absolute maximum ratings
(Tc=25°C unless otherwise specified)

Item	Symbol	Ratings	Unit	Remarks
Drain-source voltage	VDS	280	V	
	VDSX	280	V	Vgs=-30V
Continuous Drain Current	ID	56	A	
Pulsed Drain Current	ID(puls)	±224	A	
Gate-Source Voltage	VGS	±30	V	
Maximum Avalanche current	IAR	56	A	Note 1
Non-Repetitive	EAS	10391	mJ	Note 2
Maximum Avalanche Energy	EAR	41	mJ	Note 3
Repetitive Maximum Avalanche Energy				
Maximum Drain-Source dV/dt	dVDS/dt	20	kV/μs	Vds≤280V
Peak Diode Recovery dV/dt	dV/dt	5	kV/μs	Note 4
Max. Power Dissipation	Pd	410	W	Tc=25°C
		2.50		Ta=25°C
Operating and Storage Temperature range	T _{on}	+150	°C	
	T _{stg}	-55 to +150	°C	

● Electrical characteristics (Tc =25°C unless otherwise specified)
■ Outline Drawings (mm) 200407

Note: 1. Guaranteed mark of avalanche ruggedness.

DIMENSIONS ARE IN MILLIMETERS.

■ Equivalent circuit schematic

Note *1: Tch≤150°C, Repetitive and Non-repetitive

Note *2: Starting Tch=25°C, IAS=23A, L=3.37mH,

Vce=48V, RG=50Ω

EAS limited by maximum channel temperature and Avalanche current.

See to the 'Avalanche Energy' graph

Note *3: Repetitive rating: Pulse width limited by maximum channel temperature.

See to the 'Transient Thermal impedance' graph.

Note *4: If≤-Id, -di/dt=50A/μs, Vcc≤BVdss, Tch≤150°C

Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain-Source Breakdown Voltage	BVDSS	Id= 250μA VGS=0V	280			V
Gate Threshold Voltage	VGS(th)	Id= 250μA VDS=VGS		3.0	5.0	V
Zero Gate Voltage Drain Current	IdSS	VDS=280V VGS=0V VDS=224V VGS=0V			25	μA
		Tch=25°C Tch=125°C			250	
Gate-Source Leakage Current	IGSS	VGS=±30V VDS=0V			100	nA
Drain-Source On-State Resistance	RDS(on)	Id=28A VGS=10V		51	61	mΩ
Forward Transconductance	gfs	Id=28A VDS=25V	12	24		S
Input Capacitance	Ciss	VDS=75V		3600	5400	pF
		VGS=0V		530	795	
Output Capacitance	Coss	f=1MHz		35	52.5	
Reverse Transfer Capacitance	Crss					
Turn-On Time t _{on}	t _{d(on)}	Vcc=180V Id=28A		40	60	ns
	tr	VGS=10V		58	87	
Turn-Off Time t _{off}	t _{d(off)}	R _{GS} =10Ω		80	120	
	tf			10	15	
Total Gate Charge	QG	Vcc=140V		80	120	nC
Gate-Source Charge	QGS	Id=56A		30	45	
Gate-Drain Charge	QGD	VGS=10V		25	38	
Diode forward on-voltage	VSD	If=56A VGS=0V Tch=25°C		1.20	1.50	V
Reverse recovery time	trr	If=56A VGS=0V		400		ns
		-di/dt=100A/μs Tch=25°C		4.5		μC

● Thermal characteristics

Item	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Thermal resistance	R _{th(ch-c)}	channel to case			0.305	°C/W
	R _{th(ch-a)}	channel to ambient			50.0	°C/W

■ Characteristics

